Notice of References Cited Application/Control No. 09/836,989 Examiner Sargon N. Nano Applicant(s)/Patent Under Reexamination HOFFMAN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,889,194	05-2005	Kadaba, Nagesh	705/1
	В	US-6,125,352	09-2000	Franklin et al.	705/26
	С	US-6,832,201	12-2004	Leymann et al.	705/7
	D	US-5,710,887	01-1998	Chelliah et al.	705/26
	E	US-			
	F	US-		•	
	G	US-			
	Н	US-			
	١.	US-			
	J.	US			
	К	US-			
	Ļ	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification			
	Ν								
	0								
	Р								
<u>.</u>	Q								
	R								
	S								
	Т								

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
	٧		
	W		
	X		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.